

**Search Notes**

Application/Control No.

09/588,617

Examiner

Trung Q. Nguyen

Applicant(s)/Patent under  
Reexamination

BERTIN ET AL.

Art Unit

2829

**SEARCHED**

| Class | Subclass | Date | Examiner |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE     | EXMR |
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| East Search<br>Keywords: semiconductor\$1,<br>carrier\$1, socket\$1, burn\$3, test\$3<br>and chip\$1 | 9/7/2005 | QT   |
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